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Application Number	10/077,960	
	02/19/2002	
First Named Inventor	Patrick R. Connelly	
Art Unit	3762	
Examiner Name		
Attorney Docket Number	BTI-2	

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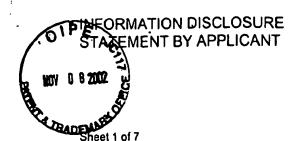




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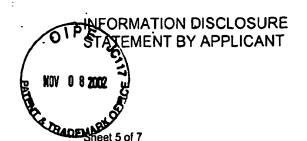
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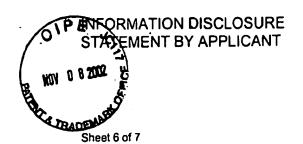
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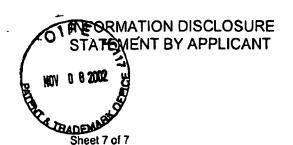
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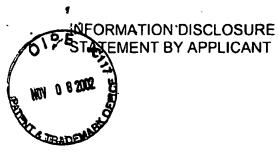
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